

STW13NK80Z

N-channel 800V - 0.53Ω - 12A - TO-247 Zener-protected SuperMESH™ Power MOSFET

General features

Туре	V _{DSS}	R _{DS(on)}	I _D	p _W
STW13NK80Z	800V	<0.65Ω	12A	230W

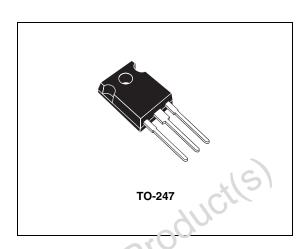
- Extremely high dv/dt capability
- 100% avalanche tested
- Gate charge minimized
- Very low intrinsic capacitances
- Very good manufacturing repeatibility

Description

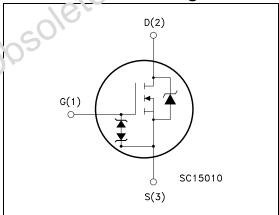
The SuperMESH™ series is obtained through an extreme optimization of ST's well established strip-based PowerMESH™ layout. In addition to pushing on-resistance significantly down, special care is taken to ensure a very good dv/dt capability for the most demanding applications. Such series complements ST full range of high voltage MOSFETs including revolutionary MDmesh™ products.

Applications

■ Switching application



Internal schematic diagram



Order codes

Part number	Marking	Package	Packaging
STW13NK80Z	W13NK80Z	TO-247	Tube

October 2006 Rev 4 1/14

Contents STW13NK80Z

Contents

1	Electrical ratings 3
	1.1 Protection features of gate-to-source zener diodes 4
2	Electrical characteristics 5
	2.1 Electrical characteristics (curves)
3	Test circuit9
4	Package mechanical data11
5	Revision history
	Package mechanical data
Obsoli	



STW13NK80Z Electrical ratings

1 Electrical ratings

Table 1. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _{DS}	Drain-source voltage (V _{GS} = 0)	800	V
V _{GS}	Gate- source voltage	± 30	V
I _D	Drain current (continuous) at T _C = 25°C	12	Α
I _D	Drain current (continuous) at T _C = 100°C	7.6	Α
I _{DM} ⁽¹⁾	Drain current (pulsed)	48	Α
P _{tot}	Total dissipation at T _C = 25°C	230	W
	Derating Factor	1.85	W/°C
E _{AS} (2)	Single pulse avalanche energy	4.5	mJ
T _{stg}	Storage temperature	-55 to 150	Sec
T _j	Max. operating junction temperature	-55 10 150	

^{1.} Pulse width limited by safe operating area.

Table 2. Thermal data

Rthj-case	Thermal resistance junction-case max	0.54	°C/W
Rthj-amb	Thermal resistance junction-ambient max	50	°C/W
T _J	Maximum lead temperature for soldering purpose	300	°C

Table 3. Avalanche characteristics

Symbol	Parameter	Max value	Unit
I _{AR}	Avalanche current, repetitive or not-repetitive (pulse width limited by T_j max)	12	Α
E _{AS}	Single pulse avalanche energy (starting $T_j = 25$ °C, $I_D = I_{AR}$, $V_{DD} = 50$ V)	450	mJ

Table 4. Gate-source zener diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
BV _{GSO}	Gate-source breakdown voltage	Igs=± 1mA (open drain)	30			V

^{2.} $I_{SD} \leq 2A$, di/dt $\leq 200A/\mu s$, $V_{DD} \leq V_{(BR)DSS}$, $T_j \leq T_{JMAX}$.

Electrical ratings STW13NK80Z

1.1 Protection features of gate-to-source zener diodes

The built-in back-to-back Zener diodes have specifically been designed to enhance not only the device's ESD capability, but also to make them safely absorb possible voltage transients that may occasionally be applied from gate to source. In this respect the Zener voltage is appropriate to achieve an efficient and cost-effective intervention to protect the device's integrity. These integrated Zener diodes thus avoid the usage of external components.



2 Electrical characteristics

(T_{CASE}=25°C unless otherwise specified)

Table 5. On/off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$I_D = 1$ mA, $V_{GS} = 0$	800			V
I _{DSS}	Zero gate voltage drain current (V _{GS} = 0)	V_{DS} = max rating V_{DS} = max rating, T_{C} = 125°C			1 50	μ Α μ Α
I _{GSS}	Gate-body leakage current (V _{DS} = 0)	V _{GS} = ± 20V			±10	μА
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 100 \mu A$	3	3.75	4.5	٧
R _{DS(on)}	Static drain-source on resistance	$V_{GS} = 10V, I_{D} = 6A$		0.53	0.65	Ω

Table 6. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
9 _{fs} ⁽¹⁾	Forward transconductance	$V_{DS} = 15V, I_{D} = 6A$		11		S
C _{iss} C _{oss} C _{rss}	Input capacitance Output capacitance Reverse transfer capacitance	$V_{DS} = 25V$, $f = 1MHz$, $V_{GS} = 0$		3480 312 67		pF pF pF
C _{oss eq} ⁽²⁾	Equivalent output capacitance	$V_{GS} = 0V, V_{DS} = 0V$ to 720V		150		pF
$t_{\rm d(on)} \\ t_{\rm r} \\ t_{\rm d(off)} \\ t_{\rm f}$	Turn-on delay time Rise time Turn-off delay time Fall time	V_{DD} = 400V, I_D = 6A R_G = 4.7 Ω V_{GS} = 10V (see <i>Figure 13</i>)		33 22 95 55		ns ns ns
$egin{array}{c} Q_{ m g} \ Q_{ m gs} \ Q_{ m gd} \end{array}$	Total gate charge Gate-source charge Gate-drain charge	V_{DD} = 640V, I_{D} = 12A, V_{GS} = 10V, R_{G} = 4.7 Ω (see <i>Figure 14</i>)		115 31 51	155	nC nC nC

^{1.} Pulsed: Pulse duration = 300 μ s, duty cycle 1.5 %.

^{2.} Coss eq. is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS} .

Electrical characteristics STW13NK80Z

Table 7. Source drain diode

Symbol	Parameter	Test conditions	Min.	Tvo	Max.	Unit
Syllibol		rest conditions	IVIIII.	Тур.	wax.	Offic
I _{SD}	Source-drain current Source-drain current				12	Α
I _{SDM} ⁽¹⁾	(pulsed)				48	Α
V _{SD} ⁽²⁾	Forward on voltage	I _{SD} = 12A, V _{GS} = 0			1.6	٧
t _{rr}	Reverse recovery time	$I_{SD} = 12A$, di/dt = 100A/ μ s,		632		ns
Q_{rr}	Reverse recovery charge	$V_{DD} = 100V, T_j = 25^{\circ}C$		7.2		μC
I _{RRM}	Reverse recovery current	(see Figure 15)		26		Α
t _{rr}	Reverse recovery time	$I_{SD} = 12A$, di/dt = 100A/ μ s,		805		ns
Q _{rr} I _{RRM}	Reverse recovery charge Reverse recovery current	$V_{DD} = 100V, T_j = 150^{\circ}C$ (see <i>Figure 15</i>)		10 25		μC A
. Fuisea: P	uise duration = 300 µs, duty cy	UIC 1.9 70		AU.	cile	
		is solete	510			
· e P	coduci(s)	a. cle 1.5 %	Sic			

2.1 Electrical characteristics (curves)

Figure 1. Safe operating area

Figure 2. Thermal impedance

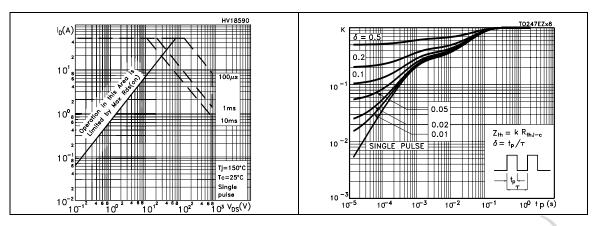


Figure 3. Output characterisics

Figure 4. Transfer characteristics

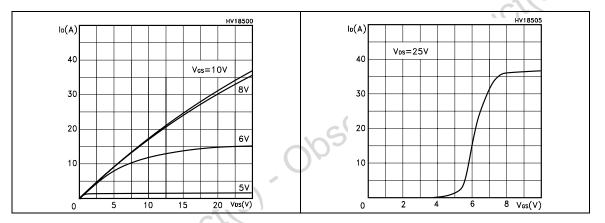
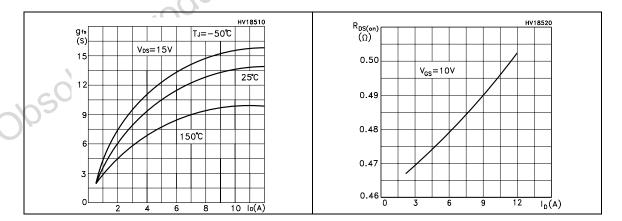


Figure 5. Transconductance

Figure 6. Static drain-source on resistance



Electrical characteristics STW13NK80Z

Figure 7. Gate charge vs gate-source voltage Figure 8. Capacitance variations

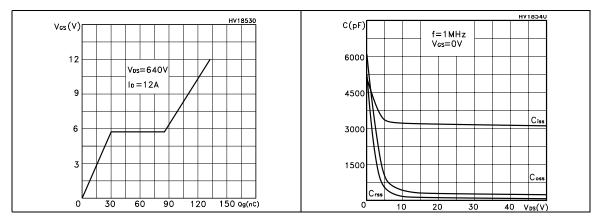


Figure 9. Normalized gate threshold voltage vs temperature

Figure 10. Normalized on resistance vs temperature

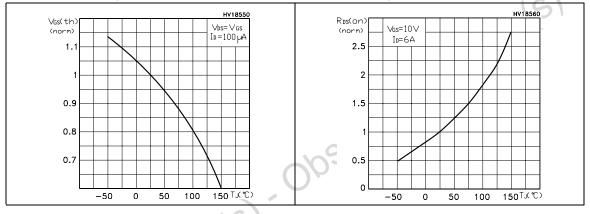
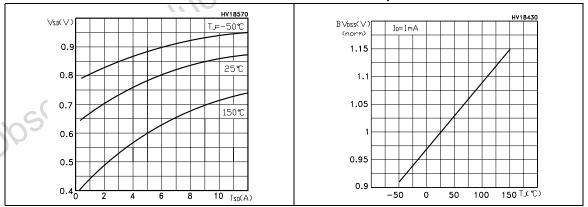


Figure 11. Source-drain diode forward characteristics

Figure 12. Normalized breakdown voltage vs temperature



STW13NK80Z Test circuit

3 Test circuit

Figure 13. Switching times test circuit for resistive load

Figure 14. Gate charge test circuit

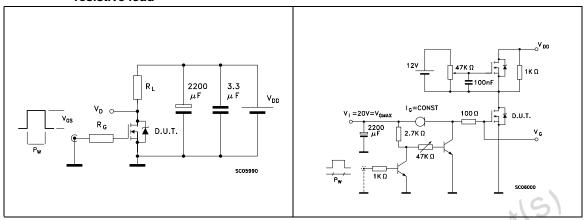
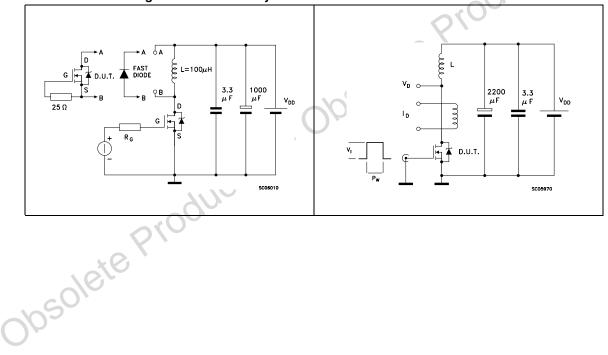


Figure 15. Test circuit for inductive load switching and diode recovery times

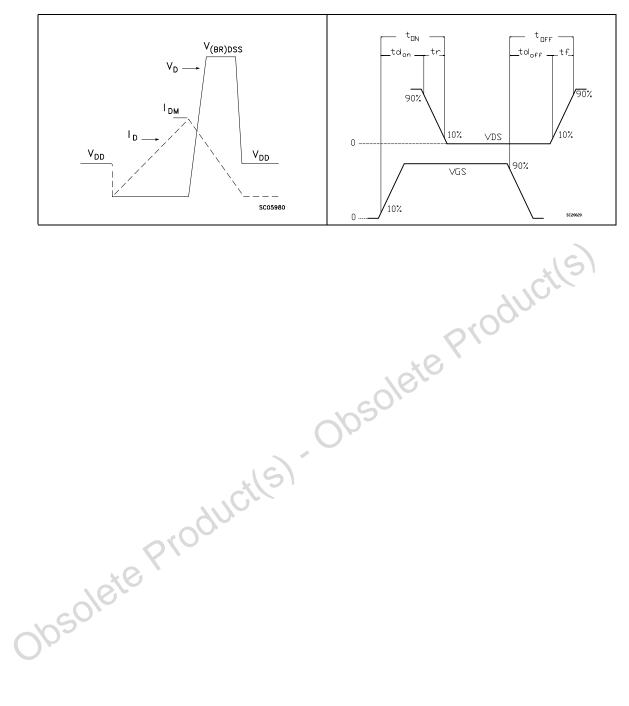
Figure 16. Unclamped Inductive load test circuit



Test circuit STW13NK80Z

Figure 17. Unclamped inductive waveform

Figure 18. Switching time waveform



4 Package mechanical data

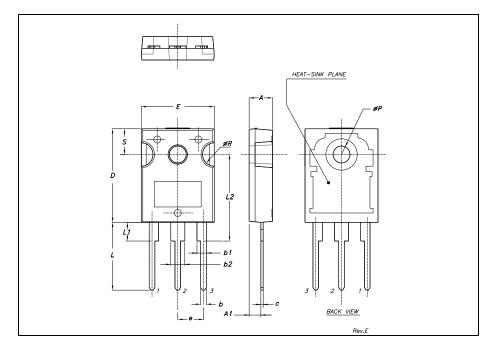
In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com

Obsolete Product(s). Obsolete Product(s)

577

TO-247 MECHANICAL DATA

DIM.		mm.			inch	
DIN.	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
Α	4.85		5.15	0.19		0.20
A1	2.20		2.60	0.086		0.102
b	1.0		1.40	0.039		0.055
b1	2.0		2.40	0.079		0.094
b2	3.0		3.40	0.118		0.134
С	0.40		0.80	0.015		0.03
D	19.85		20.15	0.781		0.793
E	15.45		15.75	0.608		0.620
е		5.45			0.214	
L	14.20		14.80	0.560		0.582
L1	3.70		4.30	0.14		0.17
L2		18.50			0.728	
øΡ	3.55		3.65	0.140		0.143
øR	4.50		5.50	0.177		0.216
S		5.50			0.216	





577

STW13NK80Z Revision history

5 Revision history

Table 8. Revision history

Date	Revision	Changes
21-Jun-2004	3	Complete document
17-Oct-2006	4	New template, no content change



Please Read Carefully:

Information in this document is provided solely in connection with ST products. STMicroelectronics NV and its subsidiaries ("ST") reserve the right to make changes, corrections, modifications or improvements, to this document, and the products and services described herein at any time, without notice.

All ST products are sold pursuant to ST's terms and conditions of sale.

Purchasers are solely responsible for the choice, selection and use of the ST products and services described herein, and ST assumes no liability whatsoever relating to the choice, selection or use of the ST products and services described herein.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted under this document. If any part of this document refers to any third party products or services it shall not be deemed a license grant by ST for the use of such third party products or services, or any intellectual property contained therein or considered as a warranty covering the use in any manner whatsoever of such third party products or services or any intellectual property contained therein.

UNLESS OTHERWISE SET FORTH IN ST'S TERMS AND CONDITIONS OF SALE ST DISCLAIMS ANY EXPRESS OR IMPLIED WARRANTY WITH RESPECT TO THE USE AND/OR SALE OF ST PRODUCTS INCLUDING WITHOUT LIMITATION IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE (AND THEIR EQUIVALENTS UNDER THE LAWS OF ANY JURISDICTION), OR INFRINGEMENT OF ANY PATENT, COPYRIGHT OR OTHER INTELLECTUAL PROPERTY RIGHT.

UNLESS EXPRESSLY APPROVED IN WRITING BY AN AUTHORIZED ST REPRESENTATIVE, ST PRODUCTS ARE NOT RECOMMENDED, AUTHORIZED OR WARRANTED FOR USE IN MILITARY, AIR CRAFT, SPACE, LIFE SAVING, OR LIFE SUSTAINING APPLICATIONS, NOR IN PRODUCTS OR SYSTEMS WHERE FAILURE OR MALFUNCTION MAY RESULT IN PERSONAL INJURY, DEATH, OR SEVERE PROPERTY OR ENVIRONMENTAL DAMAGE. ST PRODUCTS WHICH ARE NOT SPECIFIED AS "AUTOMOTIVE GRADE" MAY ONLY BE USED IN AUTOMOTIVE APPLICATIONS AT USER'S OWN RISK.

Resale of ST products with provisions different from the statements and/or technical features set forth in this document shall immediately void any warranty granted by ST for the ST product or service described herein and shall not create or extend in any manner whatsoever, any liability of ST.

ST and the ST logo are trademarks or registered trademarks of ST in various countries.

Information in this document supersedes and replaces all information previously supplied.

The ST logo is a registered trademark of STMicroelectronics. All other names are the property of their respective owners.

© 2006 STMicroelectronics - All rights reserved

STMicroelectronics group of companies

Australia - Belgium - Brazil - Canada - China - Czech Republic - Finland - France - Germany - Hong Kong - India - Israel - Italy - Japan - Malaysia - Malta - Morocco - Singapore - Spain - Sweden - Switzerland - United Kingdom - United States of America

www.st.com

47/